

#### 1. Scope:

#### 1.1 Contents

This specification covers the requirements for product performance test methods and quality requirement for 0.5 mm Pitch FPC SMT Connector (Back Flip).

The applicable product descriptions and part numbers are as shown in Appendix 1.

#### 2. Applicable Documents:

The following documents form a part of this specification to the extent specified herein. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence. In the event of conflict between the requirements of this specification and the referenced documents, this specification shall take precedence.

#### 2.1 TE Specifications:

- A. 108-115142: Test Specification, General Requirements for Test Methods
- B. 501-115157: Test Report for 0.5mm pitch FPC SMT Connector
- C. 109-1: General Requirement for Test Specifications
- D. 109-201: Component Heat Resistance to Lead-Free Reflow Soldering

#### 2.2 Commercial Standards and Specifications:

A. MIL-STD-202: Test Methods for Electronic and Electrical Component Parts.

#### 3. Requirements

#### 3.1 Design and Construction

Product shall be of the design, construction and physical dimensions specified on the applicable product drawing.

#### 3.2 Materials:

- A: Housing: Thermoplastic, UL94V-0
- B: Actuator: Thermoplastic, UL94V-0
- C: Fitting nail: Stainless steel, Tin Plated over Nickel under-plating,
- D: Contact: Copper Alloy, Gold Plated over Nickel under-plating,

#### 3.3 Ratings:

- A. Temperature Rating; -40 °C to +85 °C
- B. Voltage Rating; 50 VAC rms.
- C. Current Rating; 0.5A

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## **Product Specification**

### 3.4 Performance Requirements and Test Descriptions:

The product shall be designed to meet the electrical, mechanical and environmental performance requirements specified in Fig. 1. All tests shall be performed at ambient environmental conditions per TE Specification 109-1 test requirement and performance summary.

#### 3.5 Applicable

This specification applies to two times reflow later.

#### 3.6 Test Requirements and Procedures Summary

	Fig. 1								
Para.	Test Items	Requirements	Procedures						
3.6.1	Examination of Product	Meets requirements of product drawing.	Visual inspection No physical damage						
	Electrical Requirements								
3.6.2	Contact Resistance (Low Level)	50mΩ Max. (Initial) 80mΩ Max. (Final)	Subject matted contacts assembled in housing to 20 mV MAX open circuit at 100 mA Max. EIA-364-68B.						
3.6.3	Dielectric withstanding voltage	No creeping discharge or flashover shall occur. Current leakage: 0.5 mA MAX.	250VAC for 1 minute Test between adjacent circuits of unmated connector. EIA-364-20B						
3.6.4	Insulation resistance	500 MΩ MIN.	Impressed voltage 250VDC Test between adjacent circuits of unmated connector. EIA-364-21C.						
3.6.5	Temperature rising	30 °C MAX. under loaded specified current.	Measure temperature rising by energized current. (measurement of time) EIA-364-70B						
		Mechanical Requirements	5						
3.6.6	Durability	See note	Operation speed: 25.4mm/min. Durability cycles:20 cycles EIA-364-9C						
3.6.7	vibration	No electrical discontinuity greater than 1 µsec shall occur. See note.	Subject mated connectors to 10-55-10 HZ Traversed in 1 minutes at 1.52 mm amplitude 2 hours each of 3 mutually perpendicular planes. 100 mA MAX. Applied. EIA-364-28D						
3.6.8	Mechanical shock	No electrical discontinuity greater than 1 µsec shall occur. See note.	Accelerate velocity: 490m/s2 (50G) Waveform: Half-sine shock plus Duration: 11msec Velocity change: 3.4m/s No. of drops: 3 drops each to normal and reversed directions of X.Y and Z axes, totally 18 drops, passing DC 100mA current during the test. EIA-364-27B						
3.6.9	Contact retention force	0.20N/Pin MIN.	Measure the contact retention force with tensile strength tester. EIA-364-29B						

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3.6.10	FPC retention force	The actuator retention force shall be more than 0.2 N X Pin NO. MIN.	While applying a axial pulling force to the support member of the plug or receptacle EIA-364-13B						
3.6.11	Solderability	The inspected area of each lead must have 95% Solder Coverage minimum.	Steam aging preconditioning: 93+3/-5 °C,100% HR,8 Hrs. <jesd22-b102d, c="" condition=""> Solder pot Temperature: 260 ± 5 °C Immersion Duration:5 ± 0.5 seconds</jesd22-b102d,>						
	Environmental Requirements								
3.6.12	Resistance to reflow Soldering Heat	No physical damage shall occur.	Pre-soak condition, 85°C/95%RH, 168 Hrs. Pre-heat: 150~200°C,60~180sec. Peak temp:260+/5°C,20~40sec. Duration:3 cycles TE spec.109-201, condition B						
3.6.13	Thermal Shock	See Note	Mated connector, -55°C(30 minutes)~ 85°C (30minutes).,perform this a cycle,repeat 5 cycles EIA-364-32C						
3.6.14	Humidity-Temperature Life	See Note	Mated connector,25°C~ 65°C.,90~95% RH ,10 cycles EIA-364-31B						
3.6.15	Temperature Life	See Note	Mated connector 85°C, 96Hrs. EIA-364-17B						
3.6.16	Resistance to cold	See Note	Mated connector -40°C, 96Hrs.						
3.6.17	Humidity (Steady state)	See Note	mated connectors shall be stored at temperature of 40+/-2°C with relative humidity 90~95%RH for 96 hours, After test, it shall be subjected to standard atmospheric condition for 1 hour, after which measurement shall be made. EIA-364-31B						
3.6.18	Salt spray	No detrimental corrosion allowed in contact area and base metal exposed.	Subject mated connectors to 35+/-2°C and 5+/-1% salt condition for 48 hours. After test, rince the sample with water and recondition the room temperature for 1 hour. EIA-364-26B.						

Fig. 1 (End.)

Note: shall meet visual requirement, show no physical damage, and meet requirement of additional tests as specified in the test sequence in figures 2.

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	•			Fi	g. 2					
	Test Group									
Test or Examination	A	В	С	D	E Toot So	F	G	H		J
		Test Sequence (a)								
Examination of Product	1,9	1,3	1,7	1,6	1,3	1,3	1,3	1,7	1,7	1,5
Contact resistance	2,8		2,6	2,5				2,4,6	2,4,6	2,4
Dielectric withstanding voltage	4,6									
Insulation resistance	3,7									
Temperature rising		2								
Durability			4							
Vibration				3						
Mechanical shock				4						
Contact retention force					2					
FPC retention force			3,5							
Solderability						2				
Resistance to reflow Soldering Heat							2			
Thermal Shock								3		
Humidity- temperature cycle								5		
Temperature Life									3	
Resistance to cold									5	
Humidity (steady state)	5									
Salt spray										3
No.of test samples	5	5	5	5	5	5	5	5	5	5

Note: (a) Numbers indicate sequence in which the tests are performed.

(b) discontinuities shall not take place in this test group, during tests.

The applicable product descriptions and part numbers are as shown in Appendix. 1.

Product Part No.	Description	Test Report		
2328702-4	4pin,0.5mm pitch FPC connector ( back flip lock)	501-115157		
2328702-6	6pin,0.5mm pitch FPC connector ( back flip lock)	501-115157		
2328702-8	8pin,0.5mm pitch FPC connector ( back flip lock)	501-115157		
1-2328702-0	10pin,0.5mm pitch FPC connector ( back flip lock)	501-115157		



# **Product Specification**



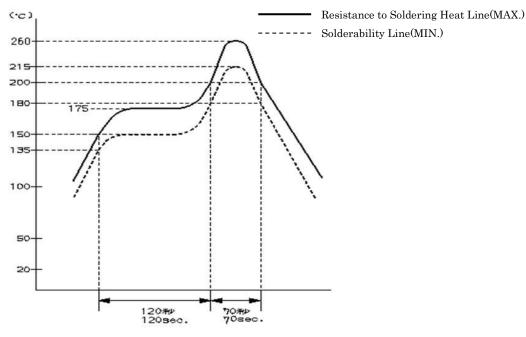


Fig. 3 Reflow Condition